

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Lawrence W. Yonge III et al. Art Unit : 2133
Serial No. : 10/720,016 Examiner : Samir Wadie Rizk
Filed : November 20, 2003 Conf. No. : 2786
Title : USING ERROR CHECKING BITS TO COMMUNICATE AN ADDRESS OR
OTHER BITS

MAIL STOP RCE

Commissioner for Patents
P.O. Box 1450
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INFORMATION DISCLOSURE STATEMENT

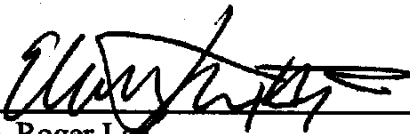
Applicants request consideration of the references listed on the attached PTO-1449 form. Applicants do not concede that the listed references are prior art. Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed. Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request.

This filing is being made with the filing of a Request for Continued Examination. No fee is required.

Respectfully submitted,

Date: _____

4-10-07



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Substitute Form PTO-1449 (Modified) Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 04838-076001	Application No. 10/720,016
		Applicant Lawrence W. Yonge III et al.	
		Filing Date November 20, 2003	Group Art Unit 2133

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	6765885	07/20/04	Jiang et al.			
	AB	5627829	05/06/97	Gleeson et al.			
	AC	2005/0122994	06/09/05	Mangin et al.			
	AD	2004/0184481	09/23/04	Lee			
	AE	2004/0008728	01/15/04	Lee			
	AF	2003/0231658	12/18/03	Liang et al.			
	AG	2003/0231652	12/18/03	Sprague et al.			
	AH	2002/0131591	09/19/02	Henson et al.			
	AI	2002/0001314	01/03/02	Yi et al.			
	AJ	2001/0012319	08/09/01	Foley			

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AK							
	AL							
	AM							
	AN							
	AO							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AP	
	AQ	
	AR	
	AS	

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	